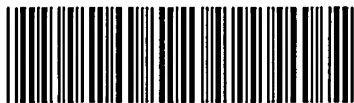


Search Notes

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10/603,816

Examiner

Joon H. Hwang

Applicant(s)/Patent under
Reexamination

HIGASHIURA ET AL.

Art Unit

2166

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Palm See search history printout(s)	10/1/2005	JH